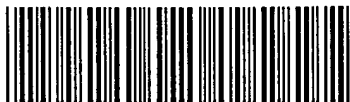


**Search Notes**

Application/Control No.

10/643,900

Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

TAKASHI IIZUKA ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	230, 243- 244, 258- 259	5/14/2005	HP
359	196, 215	5/14/2005	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
347	244, 258	5/16/2005	HP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/14/2005	HP